

SEMITOP®E2

3-phase Converter-Inverter-Brake (CIB)

Engineering Sample SK35DGDL12T7ETE2

Target Data

Features*

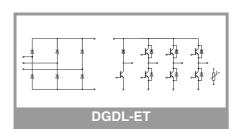
- Optimized design for superior thermal performance
- · Low inductive design
- · Press-Fit contact technology
- 1200V Generation 7 IGBT (T7)
- Robust and soft switching CAL4F diode technology
- PEP rectifier diode technology for enhanced power and environmental robustness
- Integrated NTC temperature sensor
- UL recognized file no. E 63 532

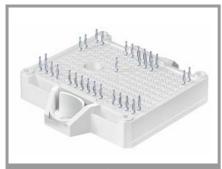
Typical Applications

- Motor drives
- Air conditioning
- Auxiliary Inverters

Remarks

Absolut	e Maximum Ratings	s		
Symbol	Conditions		Values	Unit
Inverter	- IGBT			
V _{CES}	T _i = 25 °C		1200	V
Ic	λ _{paste} =0.8 W/(mK)	T _s = 25 °C	51	Α
	T _j = 175 °C	T _s = 70 °C	41	Α
I _C	λ _{paste} =2.5 W/(mK)	T _s = 25 °C	61	Α
	T _j = 175 °C	T _s = 70 °C	50	Α
I _{Cnom}			35	Α
I _{CRM}			70	Α
V _{GES}			-20 20	V
t _{psc}	$V_{CC} = 800 \text{ V}$ $V_{GE} \le 15 \text{ V}$ $V_{CES} \le 1200 \text{ V}$	T _j = 175 °C	7	μs
Tj			-40 175	°C
Chopper	r - IGBT			
V _{CES}	T _j = 25 °C		1200	V
Ic	λ _{paste} =0.8 W/(mK)	T _s = 25 °C	51	Α
	T _j = 175 °C	T _s = 70 °C	41	Α
Ic	λ _{paste} =2.5 W/(mK)	T _s = 25 °C	61	Α
	T _j = 175 °C	T _s = 70 °C	50	Α
I _{Cnom}		•	35	Α
I _{CRM}			70	Α
V_{GES}			-20 20	V
t _{psc}	$V_{CC} = 800 \text{ V}$ $V_{GE} \le 15 \text{ V}$ $V_{CES} \le 1200 \text{ V}$	T _j = 175 °C	7	μѕ
Tj		•	-40 175	°C
Inverse -	- Diode			
V_{RRM}	T _j = 25 °C		1200	V
I _F	λ _{paste} =0.8 W/(mK)	T _s = 25 °C	41	Α
	T _j = 175 °C	T _s = 70 °C	33	Α
l _F	λ _{paste} =2.5 W/(mK)	T _s = 25 °C	49	Α
	T _j = 175 °C	T _s = 70 °C	39	Α
I _{FRM}			70	Α
I _{FSM}	$t_p = 10 \text{ ms, sin } 180^\circ$	°, T _j = 150 °C	170	Α
Tj			-40 175	°C
Freewhe	eling - Diode			
V_{RRM}	T _j = 25 °C		1200	V
I _F	λ _{paste} =0.8 W/(mK)	T _s = 25 °C	15	Α
	T _j = 175 °C	T _s = 70 °C	12	Α
I _F	λ _{paste} =2.5 W/(mK)	T _s = 25 °C	16	Α
	T _j = 175 °C	T _s = 70 °C	13	Α
I _{FRM}			20	Α
I _{FSM}	$t_p = 10 \text{ ms}, \sin 180^\circ$	°, T _j = 150 °C	36	Α
Tj			-40 175	°C





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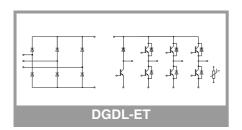
Typical Applications

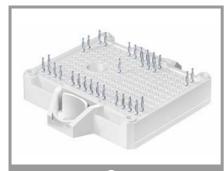
- Motor drives
- Air conditioning
- · Auxiliary Inverters

Remarks

Absolute	Maximum Ratings	S		
Symbol	Conditions		Values	Unit
Rectifier -	Diode			
V_{RRM}	T _j = 25 °C		1600	V
I _F	λ _{paste} =0.8 W/(mK)	T _s = 25 °C	61	Α
	T _j = 175 °C	T _s = 70 °C	47	Α
	λ_{paste} =2.5 W/(mK) T _j = 175 °C	T _s = 25 °C	72	Α
		T _s = 70 °C	57	Α
I _{FSM}	$t_p = 10 \text{ ms}$ $\sin 180^{\circ}$	T _j = 25 °C	370	Α
		T _j = 150 °C	270	Α
i ² t	t _p = 10 ms	T _j = 25 °C	685	A ² s
	sin 180°	T _j = 150 °C	365	A ² s
T _j		•	-40 175	°C
Module				
I _{t(RMS)}	, ΔT _{terminal} at PCB joint = 30 K, per pin		30	Α
T _{stg}	module without TIM		-40 125	°C
V _{isol}	AC, sinusoidal, 1 min		2500	V

Characte	eristics					
Symbol	Conditions		min.	typ.	max.	Unit
Inverter -	IGBT					•
V _{CE(sat)}	I _C = 35 A	T _j = 25 °C		1.60	1.75	V
	V _{GE} = 15 V	T _j = 150 °C		1.82	1.96	V
	chiplevel	T _j = 175 °C		1.86	2.00	V
V_{CE0}		T _j = 25 °C		0.90	1.00	٧
	chiplevel	T _j = 150 °C		0.75	0.83	V
	_	T _j = 175 °C		0.72	0.80	V
r _{CE}	V 45.V	T _j = 25 °C		20	21	mΩ
	V _{GE} = 15 V chiplevel	T _j = 150 °C		31	32	mΩ
		T _j = 175 °C		33	34	mΩ
$V_{GE(th)}$	$V_{GE} = V_{CE}, I_{C} = 0.75 \text{ mA}$		5.15	5.8	6.45	٧
I _{CES}	$V_{GE} = 0 \text{ V}, V_{CE} = 12$	00 V, T _j = 25 °C			1	mA
C _{ies}	V 05.V	f = 1 MHz		6.6		nF
C _{oes}	$V_{CE} = 25 \text{ V}$ $V_{GE} = 0 \text{ V}$	f = 1 MHz		0.0853		nF
C _{res}	VGE - O V	f = 1 MHz		0.024		nF
Q_{G}	V _{GE} = -15V+15V		487			nC
R _{Gint}	T _j = 25 °C			0		Ω
t _{d(on)}	V _{CC} = 600 V I _C = 35 A	T _j = 25 °C		43		ns
		T _j = 150 °C	45		ns	
	$R_{G \text{ on}} = 5.6 \Omega$	T _j = 175 °C		46		ns
t _r	$R_{G \text{ off}} = 5.6 \Omega$ $V_{GE} = +15/-15 \text{ V}$	T _j = 25 °C		30		
		T _j = 150 °C	35		ns	
	(T _i = 150 °C)	T _j = 175 °C		37		ns
E _{on}	$di/dt_{on} = 1160 \text{ A/}\mu\text{s}$ $di/dt_{off} = 620 \text{ A/}\mu\text{s}$	T _j = 25 °C		2.51		mJ
		T _j = 150 °C		3.52		mJ
	dv/dt = 4600 V/μs	T _j = 175 °C		3.96		mJ





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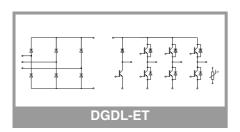
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- · Low inductive design
- Press-Fit contact technology
- 1200V Generation 7 IGBT (T7)
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- PEP rectifier diode technology for enhanced power and environmental robustness
- Integrated NTC temperature sensor
- UL recognized file no. E 63 532

Typical Applications

- Motor drives
- Air conditioning
- Auxiliary Inverters

Remarks



Characte	eristics					
Symbol	Conditions		min.	typ.	max.	Unit
Inverter -				,,		
t _{d(off)}		T _i = 25 °C		183		ns
-u(on)	$V_{CC} = 600 \text{ V}$ $I_{C} = 35 \text{ A}$	T _i = 150 °C		254		ns
	$R_{G \text{ on}} = 5.6 \Omega$	T _i = 175 °C		274		ns
t _f	$R_{G \text{ off}} = 5.6 \Omega$	T _i = 25 °C		62		ns
-1	V _{GE} = +15/-15 V	T _i = 150 °C		95		ns
	(T 150 °C)	T _i = 175 °C		102		ns
E _{off}	_ (T _j = 150 °C) di/dt _{on} = 1160 A/μs			2.83		mJ
-011	-	T _i = 150 °C		3.74		mJ
	dv/dt = 4600 V/μs	T _i = 175 °C		4.29		mJ
R _{th(j-s)}	per IGBT, λ _{paste} =0.8	ļ · ·		1.17		K/W
R _{th(j-s)}	per IGBT, λ_{paste} =2.5		0.85			K/W
Chopper		, , , , , , , , , , , , , , , , , , ,		0.00		1011
V _{CE(sat)}	1	T _i = 25 °C	1	1.60	1.75	V
V CE(sat)	$I_C = 35 \text{ A}$ $V_{GE} = 15 \text{ V}$	T _i = 150 °C		1.82	1.96	V
	chiplevel	T _i = 175 °C		1.86	2.00	V
V		T _i = 25 °C		0.90	1.00	V
V _{CE0}	chiplevel	T _i = 150 °C		0.90	0.83	V
	Criipievei	T _i = 175 °C		0.73		V
r		T _i = 25 °C		20	0.80	ļ
r _{CE}	V _{GE} = 15 V	T _i = 150 °C				mΩ
	chiplevel	$T_i = 175 ^{\circ}\text{C}$		31	32	mΩ
V		ļ · ·	F 15	33	34	mΩ V
V _{GE(th)}	$V_{GE} = V_{CE}, I_C = 0.75$		5.15	5.8	6.45	
I _{CES}	$V_{GE} = 0 \text{ V}, V_{CE} = 12$	f = 1 MHz		0.0	1	mA
Cies	V _{CE} = 25 V			6.6		nF
Coes	V _{GE} = 0 V	f = 1 MHz f = 1 MHz		0.0853		nF
C _{res}	\/ 45\/ .45\/	T = T IVITIZ		0.024		nF
Q _G	V _{GE} = -15V+15V			487		nC
R _{Gint}	T _j = 25 °C	T 05.00		0		Ω
t _{d(on)}	_	T _j = 25 °C		43		ns
		T _j = 150 °C		45		ns
•		T _j = 175 °C		46		ns
t _r	_	T _j = 25 °C		30		ns
	V _{CC} = 600 V	T _j = 150 °C		35		ns
_	$I_{\rm C} = 35 {\rm A}$	T _j = 175 °C		37		ns
E _{on}	$R_{G \text{ on}} = 5.6 \Omega$	T _j = 25 °C		2.51		mJ m J
	$R_{G \text{ off}} = 5.6 \Omega$	T _j = 150 °C		3.52		mJ
	V _{GE} = +15/-15 V	T _j = 175 °C		3.96		mJ
t _{d(off)}	(T _i = 150 °C)	T _j = 25 °C		183		ns
	$-di/dt_{on} = 1160 A/\mu s$	T _j = 150 °C		254		ns
	$di/dt_{off} = 620 A/\mu s$	1 _j = 1/5 °C		274		ns ns
t _f	dv/dt = 4600 V/μs	T _j = 25 °C		62		
	_	T _j = 150 °C		95		ns
_	_	T _j = 175 °C		102		ns
E _{off}	_	T _j = 25 °C		2.83		mJ
	_	T _j = 150 °C		3.74		mJ
		T _j = 175 °C		4.29		mJ
R _{th(j-s)}	per IGBT, λ _{paste} =0.8			1.17		K/W
$R_{th(j-s)}$	per IGBT, λ_{paste} =2.5	o W/(mK)		0.85		K/W



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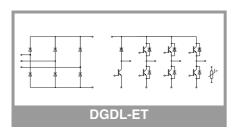
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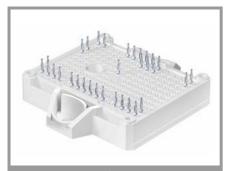
Typical Applications

- Motor drives
- Air conditioning
- Auxiliary Inverters

Remarks

Characte	eristics					
Symbol	Conditions		min.	typ.	max.	Unit
Inverse -	Diode					
$V_F = V_{EC}$	I _F = 35 A	T _i = 25 °C		2.30	2.62	V
1 10] IF = 55 A	T _i = 150 °C		2.29	2.62	V
	chiplevel	T _i = 175 °C		2.14	2.46	V
V _{F0}		T _j = 25 °C		1.30	1.50	V
10	chiplevel	T _i = 150 °C		0.90	1.10	V
	'	T _i = 175 °C		0.82	0.98	V
r _F		T _i = 25 °C		29	32	mΩ
	chiplevel	T _i = 150 °C		40	43	mΩ
	- -	T _i = 175 °C		38	42	mΩ
I _{RRM}		T _i = 25 °C		25		Α
		T _i = 150 °C		31		Α
	.,	T _i = 175 °C		37		Α
Q _{rr}	$V_{CC} = 600 \text{ V}$ $I_{F} = 35 \text{ A}$	T _i = 25 °C		2.15		μC
	$V_{GE} = -15 \text{ V}$	T _i = 150 °C		4.85		μC
	(T _j = 150 °C)	T _i = 175 °C		5.48		μC
E _{rr}	$di/dt_{off} = 1030 \text{ A/}\mu\text{s}$	T _i = 25 °C		1.46		mJ
		T _i = 150 °C		2.39		mJ
		T _i = 175 °C		3.65		mJ
R _{th(j-s)}	per Diode, λ _{paste} =0.	8 W/(mK)		1.34		K/W
R _{th(j-s)}	per Diode, λ _{paste} =2.			1.01		K/W
	eling - Diode		I			1
$V_F = V_{EC}$	I _F = 10 A	T _j = 25 °C		2.59	2.94	V
		T _j = 150 °C		2.71	3.08	V
	chiplevel	T _j = 175 °C		2.53	2.89	V
V_{F0}		T _j = 25 °C		1.30	1.50	V
	chiplevel	T _j = 150 °C		0.90	1.10	V
		T _j = 175 °C		0.82	0.98	V
r _F		T _j = 25 °C		129	144	mΩ
	chiplevel	T _j = 150 °C		181	198	mΩ
	=	T _j = 175 °C		171	191	mΩ
I _{RRM}		T _j = 25 °C		8		Α
		T _j = 150 °C		14		Α
	V _{CC} = 600 V	T _j = 175 °C		16		Α
Q _{rr}	I _F = 10 A	T _j = 25 °C		0.58		μC
	$V_{GE} = -15 \text{ V}$	T _j = 150 °C		2.01		μC
	(T _j = 150 °C)	T _j = 175 °C		2.37		μC
Err	$di/dt_{off} = 790 \text{ A/}\mu\text{s}$	T _j = 25 °C		0.36		mJ
	1	T _j = 150 °C		0.91		mJ
	1	T _j = 175 °C		1.16		mJ
R _{th(j-s)}	per Diode, λ _{paste} =0.	8 W/(mK)		2.64		K/W
R _{th(j-s)}	per Diode, λ _{paste} =2.	5 W/(mK)		2.24		K/W





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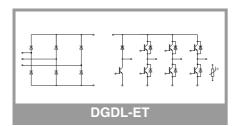
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Typical Applications

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- Air conditioning
- Auxiliary Inverters

Remarks

Characte	eristics					
Symbol	Conditions		min.	typ.	max.	Unit
Rectifier -	- Diode					
V_{F}	1 OF A	T _j = 25 °C		1.10	1.39	V
	I _F = 35 A chiplevel	T _j = 150 °C		1.04	1.33	V
		T _j = 175 °C		1.04	1.34	V
V_{F0}		T _j = 25 °C		0.89	1.09	V
	chip	T _j = 150 °C		0.73	0.92	V
		T _j = 175 °C		0.69	0.88	V
r _F		T _j = 25 °C		6.2	8.5	mΩ
	chiplevel	T _j = 150 °C		8.8	12	$m\Omega$
		T _j = 175 °C		10.0	13	mΩ
I _R	T _j = 150 °C, V _{RRM}				2	mA
R _{th(j-s)}	per Diode, λ _{paste} =0.8 W/(mK)			1.48		K/W
R _{th(j-s)}	per Diode, λ _{paste} =2.5 W/(mK)			1.14		K/W
Module						
Ms	to heatsink		1.6		2.3	Nm
w				35		g
L _{CE}				30		nH
Temperat	ture Sensor		•			
R ₁₀₀	T _c =100°C (R ₂₅ =5 kΩ)			493 ± 5%		Ω
B _{25/85}	$R_{(T)} = R_{25} * exp[E$	B _{25/85} *(1/T-1/298)], T[K]		3420		K



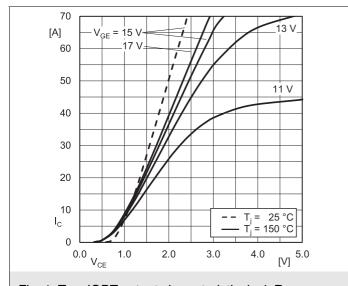


Fig. 1: Typ. IGBT output characteristic, incl. $R_{\text{CC+}\,\text{EE}}$

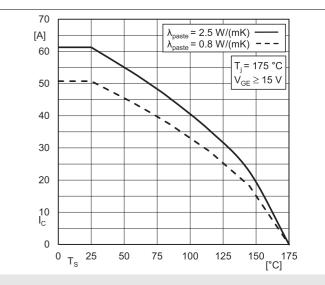


Fig. 2: IGBT rated current vs. temperature I_c=f(T_s)

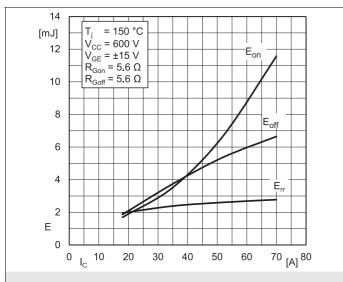


Fig. 3: Typ. turn-on /-off energy = $f(I_C)$

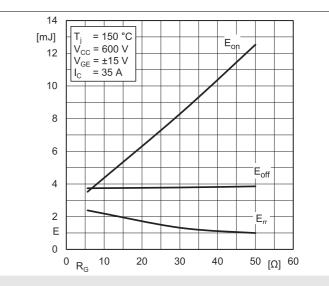


Fig. 4: Typ. turn-on /-off energy = $f(R_G)$

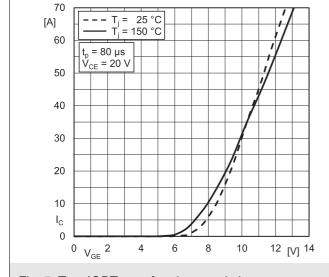


Fig. 5: Typ. IGBT transfer characteristic

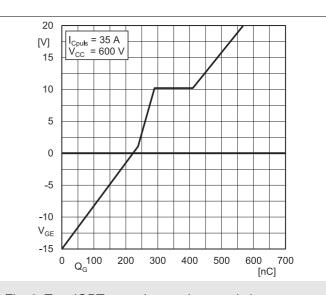
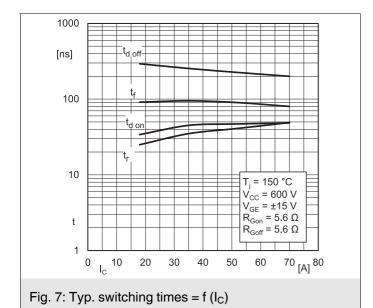
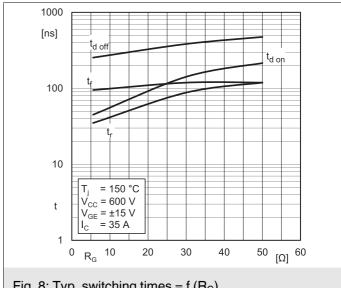


Fig. 6: Typ. IGBT gate charge characteristic







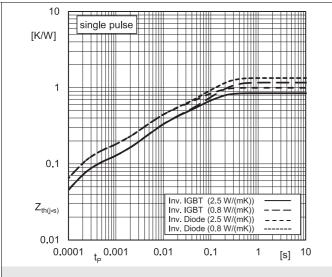


Fig. 9: Typ. transient thermal impedance

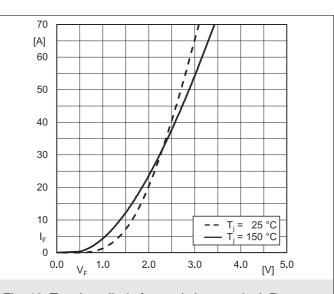


Fig. 10: Typ. Inv. diode forward charact., incl. R_{CC'+ EE'}

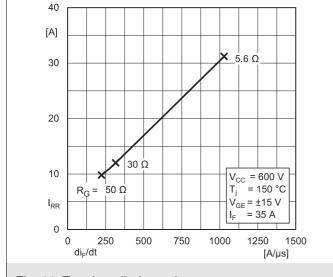


Fig. 11: Typ. Inv. diode peak reverse recovery current

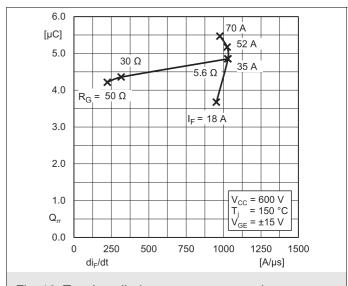


Fig. 12: Typ. Inv. diode reverse recovery charge

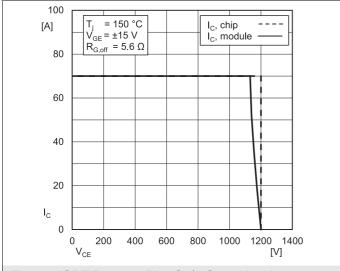


Fig. 13: IGBT Reverse Bias Safe Operating Area (RBSOA)

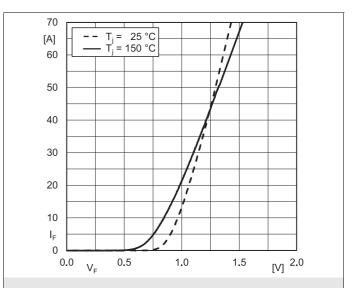
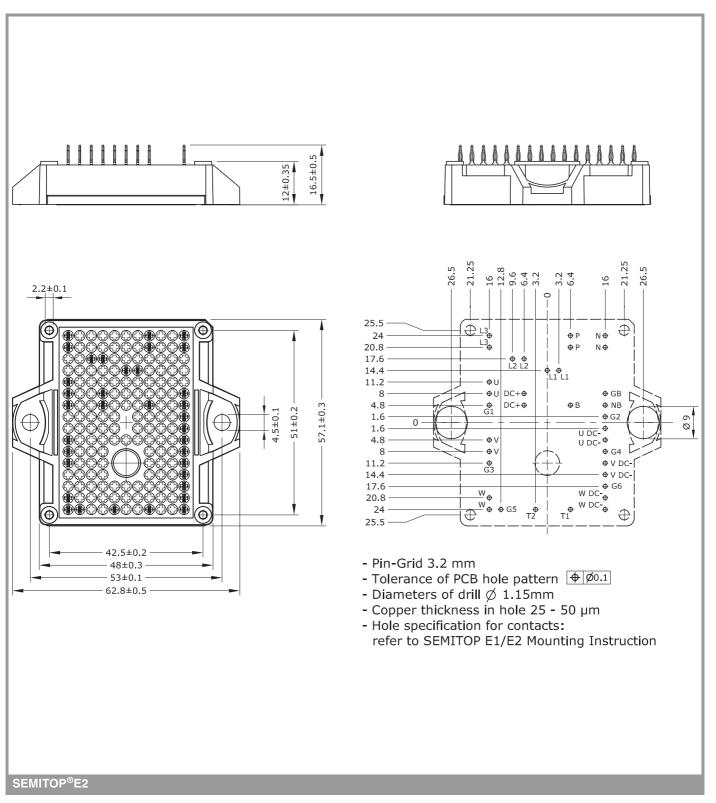
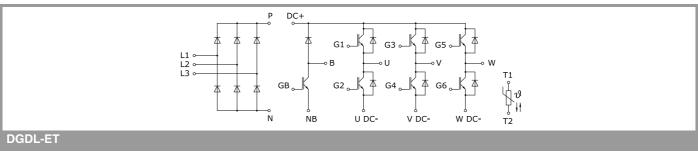


Fig. 14: Typ. Rect. diode forward charact., incl. $R_{CC'+\; EE'}$





This is an electrostatic discharge sensitive device (ESDS) due to international standard IEC 61340.

*IMPORTANT INFORMATION AND WARNINGS

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